

<b>Notice of References Cited</b>	Application/Control No. 09/820,457		Applicant(s)/Patent Under Reexamination BORG ET AL.	
	Examiner Tan Dean D. Nguyen		Art Unit 3689	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,798,997	09-2004	Hayward et al.	399/12
*	B	US-6,386,772	05-2002	Klinefelter et al.	400/208
*	C	US-6,519,571	02-2003	Guheen et al.	705/14
*	D	US-6,233,408	05-2001	Allen, Loretta E.	399/8
*	E	US-6,985,877	01-2006	Hayward et al.	705/27
*	F	US-6,029,031	02-2000	Yokomori et al.	399/109
*	G	US-6,271,643	08-2001	Becker et al.	320/112
*	H	US-2002/0075145	06-2002	Hardman et al.	340/442
*	I	US-6,067,525	05-2000	Johnson et al.	705/10
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.